

United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450
www.usplo.gov

APPLICATION NO	. F	ILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
09/963,590		09/27/2001	Mitsuru Komiyama	F00ED0023	9688		
26071	7590	11/17/2003		EXAM	EXAMINER		
JUNICHI		=	GRAYBILL, DAVID E				
OKI AMEI 1101 14TH			ART UNIT	PAPER NUMBER			
SUITE 555			2827				
WASHING	WASHINGTON, DC 20005				DATE MAILED: 11/17/2003		

Please find below and/or attached an Office communication concerning this application or proceeding.

				ton				
,	Application	No.	Applicant(s)					
Office Action Summers	09/963,590	}	KOMIYAMA ET A	L.				
Office Action Summary	Examin r		Art Unit					
	David E Gra	-	2827					
Th MAILING DATE of this communication apperiod for Reply	Th MAILING DATE of this communication appears on the cover shet with the correspondence address Period for Reply							
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely. - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication. - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). - Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b). Status								
1) Responsive to communication(s) filed on 30	July 2003.							
2a) This action is FINAL . 2b) ⊠ Thi	is action is non-	-final.						
	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
Disposition of Claims								
4)⊠ Claim(s) <u>1-36</u> is/are pending in the application	on.							
	4a) Of the above claim(s) is/are withdrawn from consideration.							
5) Claim(s) is/are allowed.	• • • • • • • • • • • • • • • • • • • •							
6)⊠ Claim(s) <u>1-36</u> is/are rejected.								
7) Claim(s) is/are objected to.	Claim(s) is/are objected to.							
8) Claim(s) are subject to restriction and	or election req	uirement.						
Application Papers								
9) The specification is objected to by the Examiner.								
10)⊠ The drawing(s) filed on <u>27 September 2001</u> is	\boxtimes The drawing(s) filed on <u>27 September 2001</u> is/are: a) \square accepted or b) \boxtimes objected to by the Examiner.							
Applicant may not request that any objection to th	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).								
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.								
Priority under 35 U.S.C. §§ 119 and 120								
 Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 13) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application) since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78. a) The translation of the foreign language provisional application has been received. 14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121 since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78. 								
Attachment(s) 1) Notice of References Cited (PTO-892)	41	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	/DTO 442) B	_\				
 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s) 	5)						

Art Unit: 2827

The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, the features of claims 3, 4, 17 and 18 must be shown or the features canceled from the claims. No new matter should be entered.

A proposed drawing correction or corrected drawings are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 32 and 36 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In claims 32 and 36 there is insufficient antecedent basis for the language "the side of the first semiconductor chip."

In the rejections infra, reference labels are generally recited only for the first recitation of identical elements.

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

Art Unit: 2827

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 13, 14, 19-23, 25, 26, 28, 31, 32, 35 and 36 are rejected under 35 U.S.C. 102(b) as being anticipated by Takiar (5422435), or in the alternative, under 35 U.S.C. 103(a) as obvious over Takiar (5422435) in combination with Fujishima (6148505).

At column 4, line 42 to column 8, line 51, and column 10, lines 57-61, Takiar teaches the following:

Art Unit: 2827

A multi-chip package type semiconductor device, comprising: a first semiconductor chip 22 having a first terminal pad 32 and a conductive relay pad 58, the conductive relay pad including a first area (any portion of the total area of the pad 58) and a second area (the portion of the total area of the pad 58 other than the first area) which is different from the first area, a second semiconductor chip 24, which is placed on the first semiconductor chip, the second semiconductor chip having a second terminal pad 54, connected (electrically and at least indirectly physically) to the conductive relay pad in the second area; a first internal terminal 46 connected to the first terminal pad; and a second internal terminal 44 connected (electrically and at least indirectly physically) to the conductive relay pad in the first area; an insulating substrate "carrier member," wherein the first and second internal terminals are formed on the insulating substrate, and the first semiconductor chip is placed on the insulating substrate, wherein the first area and the second area are inherently located along a side of the first semiconductor chip; a plurality of first terminal pads and a plurality of conductive relay pads, wherein each first terminal pad and each conductive relay pad are inherently alternatively aligned, wherein the first terminal pad is rectangularly-shaped, and a side of the first terminal pad is parallel to the side of the first semiconductor chip.

Application/Control Number: 09/963,590 Page 5

Art Unit: 2827

A multi-chip package type semiconductor device, comprising: a first semiconductor chip having a first conductive portion 32 and a second conductive portion 58, the second conductive portion having a first area and a second area, which is different from the first area; a second semiconductor chip, which is placed on the first semiconductor chip, the second semiconductor chip having a third conductive portion 54, connected to the second conductive portion in the first area; a first internal terminal connected to the first conductive portion (column 6, lines 15-18); and a second internal terminal connected to the second conductive portion in the second area, wherein the first area and the second area are located along a side of the first semiconductor chip; an insulating substrate, wherein the first and second internal terminals are formed on the insulating substrate, and the first semiconductor chip is placed on the insulating substrate; a plurality of first conductive portions and a plurality of second conductive portions, wherein each first conductive portion and each second conductive portion are inherently alternatively aligned, wherein the first conductive portion is rectangularly-shaped, and a side of the first conductive portion is parallel to the side of the first semiconductor chip, wherein the first area and the second area are inherently spaced from each other.

A multi-chip package type semiconductor device, comprising: an insulating substrate; a first conductive pattern formed on the insulating

Art Unit: 2827

substrate; a first semiconductor chip mounted on the insulating substrate; a second conductive pattern 58 formed on the first semiconductor chip, the second conductive pattern having a first area and a second area, which is different from the first area; a second semiconductor chip mounted on the first semiconductor chip; a third conductive pattern 54 formed on the second semiconductor chip; a first wire 56 connected (electrically and at least indirectly physically) between the first area of the second conductive pattern and the third conductive pattern; and a second wire 60 connected (electrically and at least indirectly physically) between the second area of the second conductive pattern and the first conductive pattern, wherein the first area and the second area are located along the side of the first semiconductor chip, wherein the first area and the second area are inherently spaced each other.

Page 6

To further clarify the teaching that the terminal pads and relay pads are inherently alternatively aligned, it is noted that, at column 6, lines 38-50, Takiar teaches that there are alternative alignments other than the explicitly taught alignments. Therefore, it is inherent that the pads are aligned alternatively to the alternative alignments. Also, as illustrated in Figure 6, in the top row of pads, Takiar explicitly teaches terminal pads and relay pads alternatively (alternately) aligned.

Art Unit: 2827

Page 7

Although inherent in the teachings of Takiar, Takiar does not appear to explicitly teach the conductive relay pad including a first area and a second area which is different from the first area, the second terminal pad connected to the conductive relay pad in the second area, the second internal terminal connected to the conductive relay pad in the first area, the second conductive portion having a first area and a second area which is different from the first area, the third conductive portion connected to the second conductive portion in the first area, the second internal terminal connected to the second conductive portion in the second area, the second conductive pattern having a first area and a second area, which is different from the first area, the first wire connected between the first area of the second conductive pattern and the third conductive pattern, and a second wire connected between the second conductive pattern and the first conductive pattern.

Nevertheless, at column 4, line 36 to column 5, line 17, Fujishima teaches a conductive relay pad (P or 40) including a first area 41 and a second area (41 or Pa) and a first (5 or 5a) and second (5 or 5b) wire connected to the first and second area, respectively. In addition, it would have been obvious to substitute the relay pad and wire connection of Fujishima for the relay pad and wire connection of Takiar because

Art Unit: 2827

substitution of a known element based on its suitability for its intended has been held to be prima facie obvious. See MPEP 2144.07.

Claims 24 and 27 are rejected under 35 U.S.C. 103(a) as being unpatentable over the combination of Takiar and Fujishima as applied to claims 20 and 25.

As cited, Takiar teaches a first wire 60, the first wire having one end connected to the second terminal and the other end connected to the second conductive portion, wherein the first wire is connected to the first area and the second wire is connected to the third conductive pattern.

However, Takiar does not appear to explicitly teach the wires connected through bumps.

Nonetheless, at column 4, lines 1-39, Fujishima teaches wires 5 connected through bumps 53. Furthermore, it would have been obvious to combine the product of Fujishima with the product of Takiar because it would facilitate wire connection.

Claims 1, 2, 15, 16, 29, 30, 33 and 34 are rejected under 35 U.S.C. 103(a) as obvious over Takiar (5422435), or Takiar (5422435) in combination with any of Haba (6376904) and Fujishima (6148505).

As cited supra, Takiar teaches the following:

A multi-chip package type semiconductor device, comprising: an insulating substrate having thereon a first conductive pattern 46 and a

Art Unit: 2827

second conductive pattern 44; a first semiconductor chip having a first internal circuit on the insulating substrate, the first semiconductor chip having a first terminal pad connecting to the first internal circuit and a conductive relay pad isolated from the first terminal pad, and the conductive relay pad including a first area and a second area, which is different from the first area; a second semiconductor chip on the first semiconductor chip, the second semiconductor chip being smaller than the first semiconductor chip, and having a second internal circuit and having a second terminal pad connecting to the second internal circuit; a first bonding wire connecting the first terminal pad to the first conductive pattern; a second bonding wire 60 connecting (electrically and at least indirectly physically) the second conductive pattern to the conductive relay pad in the first area; and a third bonding wire 56 connecting (electrically and at least indirectly physically) the conductive relay pad in the second area to the second terminal pad; a plurality of first terminal pads and a plurality of conductive relay pads, wherein each first terminal pad and each conductive relay pad are inherently alternatively aligned, wherein the first terminal pad is rectangularly-shaped, and a side of the first terminal pad is parallel to the side of the first semiconductor chip, wherein the second semiconductor chip is placed on the center of the first semiconductor chip.

Art Unit: 2827

A multi-chip package type semiconductor device, comprising: an insulating substrate having a first and second conductive patterns thereon; a first semiconductor chip on the insulating substrate, the first semiconductor chip having a first internal circuit, a first terminal pad connecting to the first internal circuit and a conductive relay pad isolated from the first terminal pad; a second semiconductor chip on the first semiconductor chip, the second semiconductor chip being smaller than the first semiconductor chip, and having a second internal circuit and having a second terminal pad connecting to the second internal circuit, a first bonding wire connecting the first terminal pad to the first conductive pattern; a second bonding wire connecting the second conductive pattern to the conductive relay pad; and a third bonding wire connecting the conductive relay pad to the second terminal pad; a plurality of first terminal pads and a plurality of conductive relay pads, wherein each first terminal pad and each conductive relay pad are inherently alternatively aligned, wherein the first terminal pad is rectangularly-shaped, and a side of the first terminal pad is parallel to the side of the first semiconductor chip, wherein the second semiconductor chip is placed on the center of the first semiconductor chip.

To further clarify the teaching that the terminal pads and relay pads are inherently alternatively aligned, it is noted that at column 6, lines 38-50, Takiar teaches that there are alternative alignments other than the explicitly

Art Unit: 2827

taught alignments. Therefore, it is inherent that the pads are aligned alternatively to the alternative alignments. Also, as illustrated in Figure 6, in the top row of pads, Takiar explicitly teaches terminal pads and relay pads alternatively (alternately) aligned.

Page 11

However, Takiar does not appear to explicitly teach wherein the lengths of the first, second and third bonding wire are approximately the same.

Nevertheless, it would have been an obvious matter of design choice bounded by well known manufacturing constraints and ascertainable by routine experimentation and optimization to choose these particular relative lengths because, as cited, Takiar teaches that wire bond length is a result effective variable, and applicant has not disclosed that the dimensions are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical, and it appears prima facie that the product would possess utility using another dimension. Indeed, it has been held that mere dimensional limitations are prima facie obvious absent a disclosure that the limitations are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical. See, for example, In re Rose, 220 F.2d 459, 105 USPQ 237 (CCPA 1955); In re Rinehart, 531 F.2d 1048, 189 USPQ 143 (CCPA 1976); Gardner v. TEC Systems, Inc., 725 F.2d 1338, 220 USPQ 777

Art Unit: 2827

(Fed. Cir. 1984), cert. denied, 469 U.S. 830, 225 USPQ 232 (1984); In re Dailey, 357 F.2d 669, 149 USPQ 47 (CCPA 1966).

In any case, at column 6, lines 6-12, Haba teaches wherein the lengths of first, second and third bonding wires 440a, 440b, 440c, respectively, are approximately the same. In addition, it would have been obvious to combine the product of Haba with the product of Takiar, because it would provide desirable electrical properties.

Although inherent in the teachings of Takiar, Takiar does not appear to explicitly teach the conductive relay pad including a first area and a second area which is different from the first area, a second bonding wire connecting the second conductive pattern to the conductive relay pad in the first area; and a third bonding wire connecting the conductive relay pad in the second area to the second terminal pad.

Nevertheless, at column 4, line 36 to column 5, line 17, Fujishima teaches a conductive relay pad (P or 40) including a first area 41 and a second area (41 or Pa) and a first (5 or 5a) and second (5 or 5b) wire connected to the first and second area, respectively. In addition, it would have been obvious to substitute the relay pad and wire connection of Fujishima for the relay pad and wire connection of Takiar because substitution of a known element based on its suitability for its intended has been held to be prima facie obvious. See MPEP 2144.07.

Page 13

Application/Control Number: 09/963,590

Art Unit: 2827

Claims 3-12, 17 and 18 are rejected under 35 U.S.C. 103(a) as being unpatentable over the combination of Takiar (5422435) and Fujishima (6148505), or the combination of Takiar (5422435), Haba (6376904) and Fujishima (6148505), as applied to claims 2 and 16.

As previously cited, Takiar teaches the following:

A multi-chip package type semiconductor device comprising wherein the first bond as the beginning connection of the first bonding wire is preformed at the first terminal pad and the second bond as the ending connection of the first bonding wire is made at the first conductive pattern, wherein the first bond as the beginning connection of the second bonding wire is preformed at the second conductive pattern and the second bond as the ending connection of the third bonding wire is made at the second terminal pad, wherein the first bond as the beginning connection of the first bonding wire is preformed at the first terminal pad and the second bond as the ending connection of the first bonding wire is made at the first conductive pattern, and the second bond as the ending connection of the second bonding wire is made at the second conductive pattern, and wherein the first bond as the beginning connection of the third bonding wire is preformed at the second terminal pad, wherein the conductive relay pad is rectangularly-shaped (square), and is formed on the periphery of the first semiconductor chip, and a longer side (the top side in the length direction

Art Unit: 2827

which is inherently longer than everything shorter than the longer side) of the rectangularly-shaped conductive relay pad is parallel to a side (the top side) of the first semiconductor chip, and a shorter side (the top side in the width direction which is inherently shorter than everything longer than the shorter side) of the rectangularly-shaped conductive relay pad is parallel to a side (the top side) of the first semiconductor chip, wherein the first area is electrically connected to the first bond of the third bonding wire via the conductive relay pad, wherein the second area is electrically connected to the first bond of the second bonding wire via the conductive relay pad, wherein the first bond as the beginning connection of the first bonding wire is preformed at the first terminal pad and the second bond as the ending connection of the first bonding wire is made at the first conductive pattern, wherein the first bond as the beginning connection of the second bonding wire is preformed at the second conductive pattern and the second bond as the ending connection of the second bonding wire is made at conductive relay pad, and wherein the first bond as the beginning connection of the third bonding wire is preformed at the conductive relay pad and the second bond as the ending connection of the third bonding wire is made at the second terminal pad, wherein the first bond as the beginning connection of the first bonding wire is preformed at the first terminal pad and the second bond as the ending connection of the first bonding wire is made at the first

Page 15

Art Unit: 2827

conductive pattern, wherein the first bond as the beginning connection of the second bonding wire is preformed at the conductive pattern and the second bond as the ending connection of the second bonding wire is made at the conductive relay pad, and wherein the first bond as the beginning connection of the third bonding wire is preformed at the second terminal pad and the second bond as the ending connection of the third bonding wire is made at the conductive relay pad.

It is noted that the product of Takiar inherently possesses the structural characteristics imparted by the process limitations of claims 3, 4, 17 and 18. See In re Fitzgerald, Sanders, and Bagheri, 205 USPQ 594 (CCPA 1980).

However, Takiar does not appear to explicitly teach that the wires are connected through bumps.

Nonetheless, at column 4, lines 1-39, Fujishima teaches wires 5 connected through bumps 53. Furthermore, it would have been obvious to combine the product of Fujishima with the product of Takiar because it facilitate wire connection.

Also, Takiar does not appear to explicitly teach the second bond is made at the first area, and wherein the first bond is preformed at the conductive relay pad in the second area; wherein the first bond of the second bonding wire is preformed at the conductive relay pad in the first

Page 16

Art Unit: 2827

area; and the second bond of the third bonding wire is made at the second area, wherein a distance from the side of the first semiconductor chip to the first area is almost the same as that from the side of the first semiconductor chip to the second area, wherein the first area is spaced apart from the first bond of the third bonding wire, wherein the second area is spaced apart from the first bond of the second bonding wire, wherein the first area of the rectangularly-shaped conductive relay pad is closer to a side of the first semiconductor chip than the second area.

Regardless, as cited supra, Fujishima teaches wherein a bond of a bonding wire (5 or 5a) is preformed at a conductive relay pad 40 in a first area, and another bond of another bonding wire (5, 5b) is made at a second area (41, Pa), wherein a distance from a side of a semiconductor chip to the first area is almost the same as that from the side of the semiconductor chip to the second area, wherein the first area is spaced apart from the another bond of the another wire, wherein the second area is spaced apart from the bond of the wire, and wherein the first area of the rectangularly-shaped conductive relay pad is closer to a side of the semiconductor chip than the second area.

To further clarify the teaching wherein a distance from a side of a semiconductor chip to the first area is inherently almost the same as that from the side of the semiconductor chip to the second area, wherein the first Art Unit: 2827

area is spaced apart from the another bond of the another wire, wherein the second area is spaced apart from the bond of the wire, and wherein the first area of the rectangularly-shaped conductive relay pad is closer to a side of the semiconductor chip than the second area, it is noted that the teaching of Fujishima of the orthogonal relationship between the various relay pad configurations and the chip satisfies these limitations.

Furthermore, it would have been obvious to substitute the relay pad and wire connection of Fujishima for the relay pad and wire connection of Takiar because substitution of a known element based on its suitability for its intended has been held to be prima facie obvious. See MPEP 2144.07.

Applicant's amendment and remarks filed 2-11-3 have been fully considered, and are addressed supra and infra.

Applicant's argument that O'Conner is not prior art is deemed persuasive; hence, O'Conner is no longer relied on in the rejection of the claims.

In the remarks, at page 15, lines 9-16; page 16, lines 1-2 and 17-20; page 17, lines 4-5 and 10-12; and page 18, lines 11-13, applicant alleges that it was admitted in the previous Office action that Takiar does not teach particular elements.

These allegations are respectfully traversed because the alleged admissions were not made. Rather, it was stated that "Takiar does not

. . . .

Application/Control Number: 09/963,590

Page 18

Art Unit: 2827

appear to explicitly teach" particular limitations, some of which Takiar was otherwise relied on as teaching.

Also, applicant contends that the limitation that the lengths of the first, second and third bonding wire are approximately the same is not an obvious matter of design choice in view of Takiar because the limitation results in a particular advantage.

This contention is respectfully deemed unpersuasive because applicant has not shown that the limitations are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical. Moreover, reasons for, or advantages resulting from, doing what the applied prior art has suggested, is not demonstrative of nonobviousness. In re Kronig 190 USPQ 425, 428 (CCPA 1976); In re Lintner 173 USPQ 560 (CCPA 1972). Indeed, the prior art teaches the claimed invention; therefore, the alleged reason or advantage is an inherent result of the prior art process. Furthermore, the prior art motivation or advantage may be different than that of applicant while still supporting a conclusion of obviousness. In re Wiseman 201 USPQ 658 (CCPA 1979); Ex Parte Obiaya 227 USPQ 58 (Bd. of App. 1985).

Applicant also asserts that "the bonding wire 440a of Haba does not correspond to the first bonding wire of the invention."

This argument is respectfully deemed unpersuasive because Haba is not necessarily relied on in the rejection for this teaching. In particular,

. . . .

Application/Control Number: 09/963,590

Art Unit: 2827

Haba is relied on only for a general teaching of analogous prior art wherein the lengths of first, second and third bonding wires are approximately the same.

Page 19

Any telephone inquiry of a general nature or relating to the status (MPEP 203.08) of this application or proceeding should be directed to Group 2800 Customer Service whose telephone number is 703-306-3329.

Any telephone inquiry concerning this communication or earlier communications from the examiner should be directed to David E. Graybill at (703) 308-2947. Regular office hours: Monday through Friday, 8:30 a.m. to 6:00 p.m.

The fax phone number for group 2800 is (703) 872-9306.

David E. Graybill Primary Examiner Art Unit 2827

D.G. 13-Nov-03